

Spectro-microscopy and Nano-tomography with Transmission X-ray Microscopy

Johanna Nelson Weker

SLAC National Accelerator Laboratory, 2575 Sand Hill Rd, Menlo Park CA, 94025
jlnelson@slac.stanford.edu

Hard X-ray transmission X-ray microscopy (TXM) is an ideal tool for *in situ* and *operando* studies of functional materials and materials synthesis routes. The high energy X-rays provides relatively relaxed restrictions on *in situ* environments enabling high resolution 2D microscopy and tomography (3D microscopy)¹ across a large range of pressures and temperatures and in varying gas or liquid environments. The full field geometry of TXM allows imaging at the sub-second time scale, allowing relevant dynamics to be captured during; for example, battery cycling,^{2,3} catalysis reactions,⁴ electrochemical synthesis,⁵ and corrosion.⁶ Moreover, by tuning the incident X-ray energy to specific absorption edges, TXM can capture elemental and chemical (spectro-microscopy) changes at 30 nm resolution within a few minutes (Figure 1). Here we will present our latest *in situ* and *operando* X-ray microscopy results.

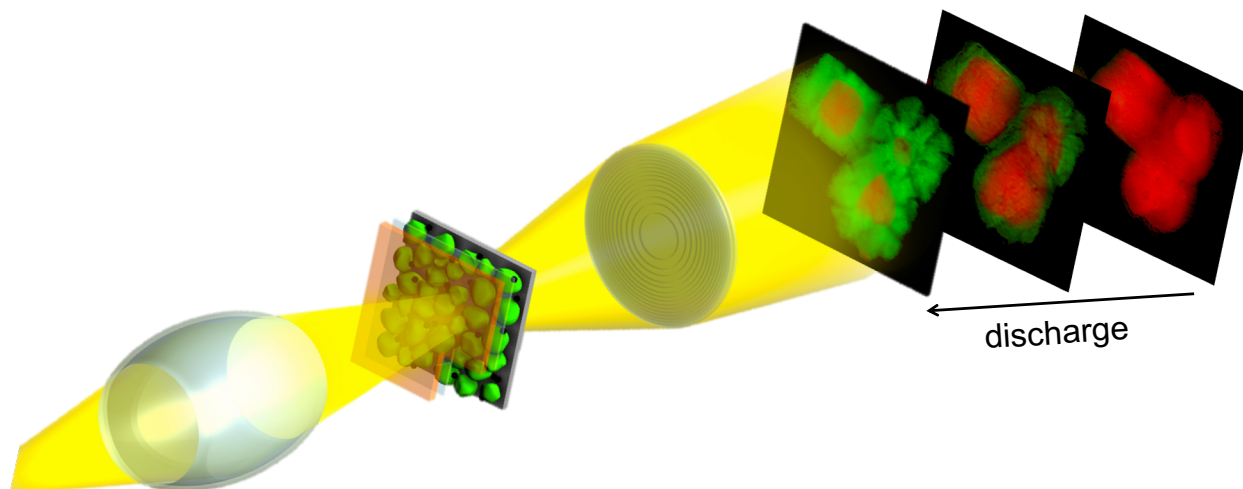


Figure 1. Spectro-microscopy of LiCoO₂ battery electrode during deep discharge.³

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